Notice of References Cited

Application/Control No. 10/563,664	Applicant(s)/Patent Under Reexamination LEE ET AL.		
Examiner	Art Unit		
JOHN F. MORTELL	4154	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,835,028 A	11-1998	Bender et al.	340/937
*	В	US-6,226,592 B1	05-2001	Luckscheiter et al.	701/301
*	С	US-6,564,122 B1	05-2003	Huertgen et al.	701/1
*	D	US-6,587,760 B2	07-2003	Okamoto, Shinichi	701/1
*	Е	US-6,825,880 B2	11-2004	Asahi et al.	348/333.02
*	F	US-6,871,717 B2	03-2005	Kada, Tomoyasu	180/167
*	G	US-6,919,822 B2	07-2005	Tanaka et al.	340/932.2
	Н	US-		-	
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	м	US-			

FOREIGN PATENT DOCUMENTS

	FOREIGN PATENT DOCUMENTS					
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	Q					
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NON DATENT DOCUMENTS

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